

Notice of References Cited	Application/Control No. 10/775,225		Applicant(s)/Patent Under Reexamination OGINO, HITOSHI	
	Examiner Richard Chan		Art Unit 2618	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,657,678	12-2003	Mizukami et al.	348/726
	B	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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